

Notice of References Cited	Application/Control No. 10/644,726	Applicant(s)/Patent Under Reexamination NAKANISHI, SHUICHI	
	Examiner Rodney Amadiz	Art Unit 2675	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,281,949	08-2001	Matsui et al.	348/750
*	B	US-6,453,067	09-2002	Morgan et al.	382/162
*	C	US-6,568,811	05-2003	Noda et al.	353/31
*	D	US-6,726,333	04-2004	Huibers et al.	353/84
*	E	US-6,831,624	12-2004	Harrold, Jonathan	345/98
*	F	US-6,961,038	11-2005	Yoshinaga et al.	345/88
*	G	US-2002/0021267	02-2002	Walker et al.	345/76
*	H	US-2002/0041708	04-2002	Pettitt, Gregory S.	382/167
*	I	US-2003/0156330	08-2003	Edlinger et al.	359/618
*	J	US-2003/0214725	11-2003	Akiyama, Takashi	359/640
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.